

**Search Notes**

Application No.

09/963,593

Examiner

David Sample

Applicant(s)

OYAMA ET AL.

Art Unit

1755

**SEARCHED**

Class	Subclass	Date	Examiner
501	64-66	7/8/2004	<i>DS</i>
	69		
	70		
	72		
	73		
	77		
	78		
	54		
313	480		
	493,636		
445	22		
	25		
	27	7/8/2004	<i>DS</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
SAME AS ABOVE		7/8/2004	<i>DS</i>

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Spoke with Christine Tierney regarding the possibility of an interference with US Patent No. 6,744,207.	7/8/2004	<i>DS</i>